

160A 650V Trench Fieldstop IGBT with anti-parallel diode SRE160N065FSUD8
General Description

The SRE160N065FSUD8 is a Field Stop Trench IGBT with anti-parallel diode, which offers ultra low conduction loss, high energy efficiency for switching applications such as Inverter, Driver, Converter, etc.

The SRE160N065FSUD8 package is TO-247Plus.

Features

- High Breakdown Voltage to 650V
- Advanced Trench Fieldstop technology
 - Short circuit ruggedness > 8us @ 25°C
 - High Ruggedness, Temperature Stability
 - Easy Parallel Switching Capability due to Positive Temperature Coefficient in $V_{CE(SAT)}$
- Low $V_{CE(SAT)}$
- Enhanced Avalanche Capability
- Non-Automotive Qualified

Application

- Motor Drives
- Inverter & Solar
- Converter with high switching frequency

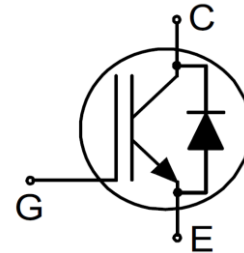
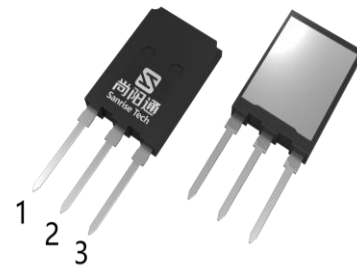
Symbol


Figure 1 Symbol of SRE160N065FSUD8

Package Type


TO-247Plus

- Pin 1- Gate
- Pin 2&backside- Collector
- Pin 3-Emitter

Figure 2 Package Type of SRE160N065FSUD8

Ordering Information

SRE160N065FSUD8 □ □ - □

Circuit Type _____	G: Green
Package _____	Blank: Tube
TP: TO-247Plus	TR: Tape & Reel

Package	Part Number	Marking ID	Packing Type
TO-247Plus	SRE160N065FSUD8TP-G1	SRE160N065FSUD8TPG1	Tube

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Absolute Maximum Ratings

Parameter		Symbol	Rating	Unit
Collector-emitter voltage		V_{CES}	650	V
Gate-emitter Voltage		V_{GES}	± 20	V
Transient Gate-emitter Voltage			± 30	V
Continuous Collector Current	$T_C=25^\circ\text{C}$	I_C	240 ⁽¹⁾	A
	$T_C=100^\circ\text{C}$		160	
Pulsed Collector Current, Limited by T_{Jmax}		I_{CM}	480	A
Diode Continuous Collector Current	$T_C=25^\circ\text{C}$	I_F	200	A
	$T_C=100^\circ\text{C}$		160	A
Diode Pulsed Current, Limited by T_{Jmax}		I_{FM}	420	A
Power Dissipation	$T_C=25^\circ\text{C}$	P_{tot}	882	W
	$T_C=100^\circ\text{C}$		441	
Short Circuit withstand time: $V_{GE}=15\text{V}, V_{CC} \leq 400\text{V}, T_{j_start}=25^\circ\text{C};$ Allow number of short circuits < 1000; Time between short circuits: 1.0S;		tsc	8	us
Operating Junction Temperature Range		T_J	$-40 \sim 175^{(2)}$	$^\circ\text{C}$
Storage Temperature		T_{STG}	$-55 \sim 150$	$^\circ\text{C}$
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	$^\circ\text{C}$

Note:

- Limited to bondwire.
- Reliability testing conducted at $T_{Jmax}=175^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
IGBT thermal Resistance, Junction-to-Case	R_{thJC}	-	-	0.17	$^\circ\text{C}/\text{W}$
Diode thermal Resistance, Junction-to-Case	R_{thJC}	-	-	0.3	
Thermal Resistance, Junction-to-Ambient	R_{thJA}	-	-	40	

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Electrical Characteristics
 $T_J = 25^\circ\text{C}$, unless otherwise specified.

Parameter		Symbol	Test Conditions	Min	Typ	Max	Unit	
Statistic Characteristics								
Collector-emitter Breakdown Voltage		BV_{CES}	$V_{GE}=0V, I_C=250\mu A$	650			V	
Gate Threshold Voltage		$V_{GE(th)}$	$V_{CE}=V_{GE}, I_C=1.6mA$	4.0	4.8	5.7	V	
Collector-emitter saturation voltage		V_{CEsat}	$V_{GE}=15V, I_C=160A,$ $T_J=25^\circ\text{C}$		1.46	1.75	V	
			$T_J=125^\circ\text{C}$		1.72		V	
			$T_J=175^\circ\text{C}$		1.89		V	
Zero Gate Voltage Collector Current		I_{CES}	$V_{CE}=650V, V_{GE}=0V$ $T_J=25^\circ\text{C}$		0.1	40	μA	
			$T_J=175^\circ\text{C}$			1	mA	
Gate-emitter Leakage Current	Forward	I_{GESF}	$V_{GE}=20V, V_{CE}=0V$			100	nA	
	Reverse	I_{GESR}	$V_{GE}=-20V, V_{CE}=0V$			-100	nA	
Dynamic Characteristics								
Input Capacitance		C_{IES}	$V_{CE}=25V, V_{GE}=0V,$ $f=100KHz$		8446		pF	
Output Capacitance		C_{OES}			585			
Reverse Transfer Capacitance		C_{RES}			113			
Gate Resistance		R_G	$f=1MHz, \text{Open Drain}$		0.5		Ω	
Turn-on Delay Time		$t_{d(on)}$	$T_J=25^\circ\text{C}$ $V_{CC}=400V, I_C=160A$ $R_G=20\Omega, V_{GE}=0/15V$ Energy losses include "tail" and diode reverse recovery		98		ns	
Rise Time		t_r			132		ns	
Turn-off Delay Time		$t_{d(off)}$			560		ns	
Fall Time		t_f			96		ns	
Turn-on energy		E_{on}			9.0		mJ	
Turn-off energy		E_{off}			5.0		mJ	
Total switching energy		E_{ts}			14.0		mJ	
Turn-on Delay Time		$t_{d(on)}$		$T_J=150^\circ\text{C}$ $V_{CC}=400V, I_C=160A$ $R_G=20\Omega, V_{GE}=0/15V$ Energy losses include "tail" and diode reverse recovery		92		ns
Rise Time		t_r				137		ns
Turn-off Delay Time		$t_{d(off)}$				665		ns
Fall Time		t_f			125		ns	
Turn-on energy		E_{on}			10.4		mJ	
Turn-off energy		E_{off}			6		mJ	
Total switching energy		E_{ts}			16.4		mJ	
Gate to Emitter Charge		Q_{GE}	$V_{CC}=400V, I_C=160A$ $V_{GE}=0 \text{ to } 15V$			87		nC
Gate to Collector Charge		Q_{GC}			124			
Gate Charge Total		Q_G			356			

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Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Reverse Diode Characteristics						
Diode Forward Voltage	V_F	$I_F=80A$ $T_J=25^\circ C$		1.50	2.0	V
		$I_F=80A$ $T_J=125^\circ C$		1.36		
		$I_F=80A$ $T_J=175^\circ C$		1.27		
		$I_F=160A$ $T_J=25^\circ C$		1.78	2.3	V
		$I_F=160A$ $T_J=125^\circ C$		1.71		
		$I_F=160A$ $T_J=175^\circ C$		1.66		
Reverse Recovery Time	t_{rr}	$T_J=25^\circ C$ $V_R=400V, I_F=80A$ $R_G=20\Omega$ $dI_F/dt=730A/\mu s$		182		ns
Reverse Recovery Charge	Q_{rr}			1.65		μC
Peak Reverse Recovery Current	I_{rrm}			26		A
Diode peak rate of fall off reverse recovery current	dI_{rr}/dt			-200		$A/\mu s$
Reverse recovery energy	E_{rec}			0.81		mJ
Reverse Recovery Time	t_{rr}	$T_J=175^\circ C$ $V_R=400V, I_F=80A$ $R_G=20\Omega$ $dI_F/dt=710A/\mu s$		404		ns
Reverse Recovery Charge	Q_{rr}			11.1		μC
Peak Reverse Recovery Current	I_{rrm}			59		A
Diode peak rate of fall off reverse recovery current	dI_{rr}/dt			-180		$A/\mu s$
Reverse recovery energy	E_{rec}			5.94		mJ
Reverse Recovery Time	t_{rr}	$T_J=25^\circ C$ $V_R=400V, I_F=160A$ $R_G=20\Omega$ $dI_F/dt=650A/\mu s$		197		ns
Reverse Recovery Charge	Q_{rr}			1.71		μC
Peak Reverse Recovery Current	I_{rrm}			26		A
Diode peak rate of fall off reverse recovery current	dI_{rr}/dt			-160		$A/\mu s$
Reverse recovery energy	E_{rec}			0.85		mJ
Reverse Recovery Time	t_{rr}	$T_J=175^\circ C$ $V_R=400V, I_F=160A$ $R_G=20\Omega$ $dI_F/dt=670A/\mu s$		463		ns
Reverse Recovery Charge	Q_{rr}			14.6		μC
Peak Reverse Recovery Current	I_{rrm}			69		A
Diode peak rate of fall off reverse recovery current	dI_{rr}/dt			-190		$A/\mu s$
Reverse recovery energy	E_{rec}			8.11		mJ



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